

**Search Notes**

Application/Control No.

10/666,860

Examiner

Dah-Wei D. Yuan

Applicant(s)/Patent under  
Reexamination

TSUKAMOTO ET AL.

Art Unit

1745

**SEARCHED**

Class	Subclass	Date	Examiner
429	94	8/3/2007	DWY
29	623.1	8/3/2007	DWY
29	623.3	8/3/2007	DWY
29	623.5	8/3/2007	DWY

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
429	94	8/3/2007	DWY
29	623.1	8/3/2007	DWY
29	623.3	8/3/2007	DWY

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	8/3/2007	DWY
Inventorship Search	8/3/2007	DWY